CD74FCT623 BICMOS OCTAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS SCBS736 - JULY 2000

•	BiCMOS Technology With Low Quiescent Power	E, M, OR SM PACKAGE (TOP VIEW)			
٠	Buffered Inputs		20] V _{CC}		
•	Noninverted Outputs	A1 [] 2	19 0EBA		
•	Input/Output Isolation From V _{CC}	A2 🛛 3	18 B1		
•	Controlled Output Edge Rates	A3 🛛 4	17 B2		
•	64-mA Output Sink Current		16 B3		
•	Output Voltage Swing Limited to 3.7 V	A5 [] 6 A6 [] 7	15 B4 14 B5		
•	SCR Latch-Up-Resistant BiCMOS Process		13 B6		
	and Circuit Design	A8 🚺 9	12 B 7		
•	Package Options Include Plastic Small-Outline (M) and Shrink Small-Outline (SM) Packages and Standard Plastic (E) DIP	GND [10	11 B8		

description

The CD74FCT623 is an octal bus transceiver that uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below V_{CC} . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes V_{CC} bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 64 mA.

This device is a noninverting, 3-state, bidirectional transceiver-buffer intended for two-way transmission from A bus to B bus or B bus to A bus, depending on the logic levels of the output-enable (OEAB, OEBA) inputs.

The dual output-enable provision gives these devices the capability to store data by simultaneously enabling OEAB and OEBA. Each output reinforces its input under these conditions, and when all other data sources to the bus lines are at high impedance, both sets of bus lines remain in their last states.

The CD74FCT623 is characterized for operation from 0°C to 70°C.

TONOTION TABLE									
INP	UTS								
OEBA	OEAB	OPERATION							
L	L	B data to A bus							
н	Н	A data to B bus							
н	L	Isolation [†]							
L	Н	B data to A bus, A data to B bus							

FUNCTION TABLE

[†] To prevent excess current in the high-impedance (isolation) state, all I/O terminals should be terminated with $10-k\Omega$ to $1-M\Omega$ resistors.



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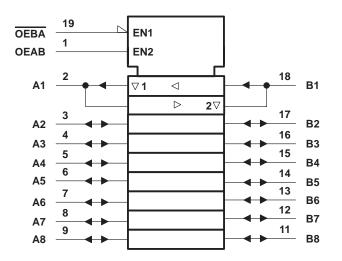
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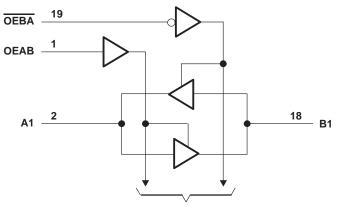
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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Transceivers



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

DC supply voltage range, V_{CC} . DC input clamp current, I_{IK} ($V_{I} < -0.5 V$) DC output clamp current, I_{OK} ($V_{O} < -0.5 V$) DC output sink current per output pin, I_{OL} DC output source current per output pin, I_{OH} Continuous current through V_{CC} , I_{CC} Continuous current through GND Package thermal impedance, θ_{JA} (see Note 1): E package	20 mA 50 mA 50 mA 30 mA
M package	
SM packageSM package SM package SM package Storage temperature range, T _{sta}	
eterage temperature range, isig	

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 2)

V _{CC} Supply voltage V _{IH} High-level input voltage V _{II} Low-level input voltage	4.75 2	5.25	V
	2		
Vii low-level input voltage			V
V _{IL} Low-level input voltage		0.8	V
VI Input voltage	0	VCC	V
V _O Output voltage	0	VCC	V
IOH High-level output current		-15	mA
IOL Low-level output current		64	mA
$\Delta t/\Delta v$ Input transition rise or fall rate	0	10	ns/V
T _A Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vaa	T _A = 25°C	MIN MAX	UNIT
FARAIMETER	TEST CONDITIONS	Vcc	MIN MAX		UNIT
VIK	lj = -18 mA	4.75 V	-1.2	-1.2	V
VOH	I _{OH} = -15 mA	4.75 V	2.4	2.4	V
VOL	I _{OL} = 64 mA	4.75 V	0.55	0.55	V
Ι	$V_{I} = V_{CC} \text{ or } GND$	5.25 V	±0.1	±1	μΑ
I _{OZ}	$V_{O} = V_{CC}$ or GND	5.25 V	±0.5	±10	μΑ
los‡	$V_{I} = V_{CC} \text{ or GND}, \qquad V_{O} = 0$	5.25 V	-60	-60	mA
ICC	$V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$	5.25 V	8	80	μΑ
∆I _{CC} §	One input at 3.4 V, Other inputs at V_{CC} or GND	5.25 V	1.6	1.6	mA
Ci	$V_I = V_{CC} \text{ or } GND$		10	10	pF
Co	$V_{O} = V_{CC} \text{ or } GND$		15	15	pF

[‡]Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.

\$ This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.



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switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C	MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	TYP			UNIT
^t pd	A or B	B or A	5.3	1.5	7	ns
	OEBA	A	7.1	1.5	9.5	-
ten	OEAB	В	7.1	1.5	9.5	ns
÷.,	OEBA	A	5.6	1.5	7.5	00
^t dis	OEAB	В	5.6	1.5	7.5	ns

noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C

	PARAMETER	MIN	TYP	MAX	UNIT
VOL(P)	Quiet output, maximum dynamic V _{OL}		V		
VOH(V)	Quiet output, minimum dynamic V _{OH}		V		
VIH(D)	High-level dynamic input voltage	2			V
V _{IL(D)}	Low-level dynamic input voltage			0.8	V

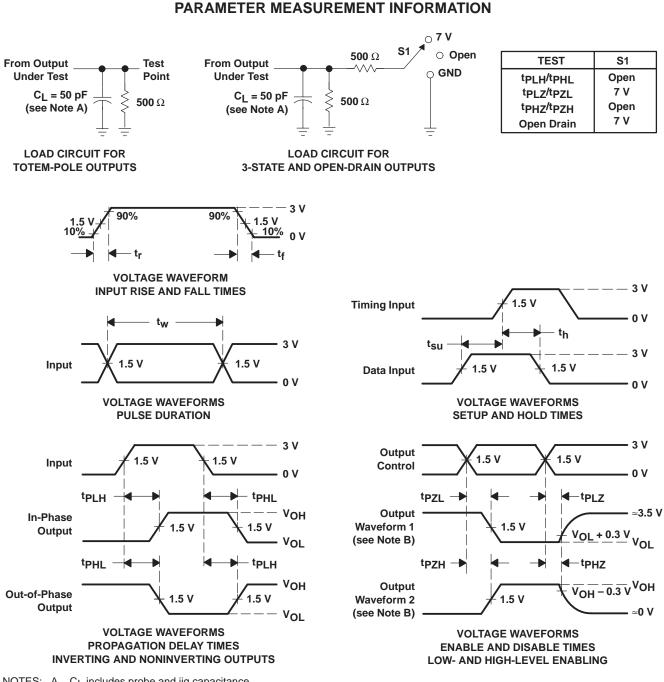
operating characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	No load, f = 1 MHz	48	pF

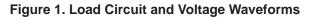


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- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \le 1$ MHz, $Z_O = 50 \Omega$, t_f and $t_f = 2.5$ ns. D. The outputs are measured one at a time with one input transition per measurement.
 - D. The outputs are measured one at a ti
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en}.
 - G. t_{PHL} and t_{PLH} are the same as t_{pd} .







6-Feb-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD74FCT623M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	0 to 70	74FCT623M	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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